Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/697,408	AKASHE ET AL.	
Examiner	Art Unit	
Anthony Weier	1761	

SEARCHED					
Class	Subclass	Date	Examiner		
426	656, 634, 574	1/9/2006	AW		
	- <u></u>				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Search	1/9/2006	AW		
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